

# **IGBT**

IGBT with integrated diode in packages offering space saving advantage

# IKD06N60R, IKU06N60R

600V TRENCHSTOP™ RC-Series for hard switching applications

# ELECTRONIC

**Datasheet** 



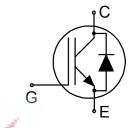
#### TRENCHSTOP™ RC-Series for hard switching applications

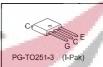
#### IGBT with integrated diode in packages offering space saving advantage

#### Features:

TRENCHSTOP™ Reverse Conducting (RC) technology for 600V applications offering

- Optimised V<sub>CEsat</sub> and V<sub>F</sub> for low conduction losses
- · Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Operating range of 1 to 20kHz
- Maximum junction temperature 175°C
- Short circuit capability of 5µs
- Best in class current versus package size performance
- Qualified according to JEDEC for target applications
- Pb-free lead plating; RoHS compliant (for PG-TO252: solder temperature 260°C, MSL1)
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

















Consumer motor drives



#### **Key Performance and Package Parameters**

Туре	<b>V</b> CE	/c	V <sub>CEsat</sub> , T <sub>vj</sub> =25°C	T <sub>vjmax</sub>	Marking	Package
IKD06N60R	600V	6A	1.65V	175°C	K06R60	PG-TO252-3
IKU06N60R	600V	6A	1.65V	175°C	K06R60	PG-TO251-3



# TRENCHSTOP<sup>TM</sup> RC-Series for hard switching applications

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## TRENCHSTOP™ RC-Series for hard switching applications

#### **Maximum ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V∕cE	600	V
DC collector current, limited by $T_{vjmax}$ $T_{C} = 25^{\circ}C$ $T_{C} = 100^{\circ}C$	<i>l</i> c	12.0 6.0	Α
Pulsed collector current, & limited by T <sub>vjmax</sub>	/Cpuls	18.0	Α
Turn off safe operating area V <sub>CE</sub> ≤ 600V, T <sub>vj</sub> ≤ 175°C	-	18.0	Α
Diode forward current, limited by $T_{vjmax}$ $T_{C} = 25^{\circ}C$ $T_{C} = 100^{\circ}C$	F	12.0 6.0	Α
Diode pulsed current, & limited by $T_{vjmax}$	Fpuls	18.0	Α
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Short circuit withstand time $V_{\text{GE}} = 15.0 \text{V}$ , $V_{\text{CC}} \le 400 \text{V}$ Allowed number of short circuits < 1000 Time between short circuits: $\ge 1.0 \text{s}$ $T_{\text{vj}} = 150 ^{\circ}\text{C}$	<i>t</i> sc	5	μs
Power dissipation $T_C = 25^{\circ}C$	Ptot	100.0	W
Operating junction temperature	<i>T</i> vj	-40+175	°C
Storage temperature	T <sub>stg</sub>	-55+175	°C
Soldering temperature, wave soldering 1.6 mm (0.063 in.) from case for 10s	PG-TO251-3	260	°C
reflow soldering (MSL1 according to JEDEC J-STA-020)	PG-TO252-3	260	

#### **Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
IGBT thermal resistance,1) junction - case	R <sub>th(j-c)</sub>		1.50	K/W
Diode thermal resistance, <sup>2)</sup> junction - case	R <sub>th(j-c)</sub>		3.60	K/W
Thermal resistance, min. footprint junction - ambient	<b>R</b> th(j⁻a)	PG-TO252-3	ONIC	K/W
Thermal resistance, 6cm² Cu on PCB junction - ambient	$R_{th(j-a)}$	PG-TO252-3	50	K/W
Thermal resistance junction - ambient	R <sub>th(j-a)</sub>	PG-TO251-3	75	K/W

<sup>&</sup>lt;sup>1)</sup> Rth/Zth based on single cooling pulse. Please be aware that a correct Rth measurement of the IGBT, is not possible using a thermocouple. <sup>2)</sup> Rth/Zth based on single cooling pulse. Please be aware that a correct Rth measurement of the Diode, is not possible using a thermocouple.



#### TRENCHSTOP™ RC-Series for hard switching applications

#### Electrical Characteristic, at $T_{vj}$ = 25°C, unless otherwise specified

Dougnatou	Symbol Conditions		Value			I I mit
Parameter			min.	typ.	max.	Unit
Static Characteristic						
Collector-emitter breakdown voltage	V(BR)CES	V <sub>GE</sub> = 0V, I <sub>C</sub> = 0.20mA	600	-	-	V
Collector-emitter saturation voltage	V∕CEsat	$V_{GE} = 15.0V$ , $I_{C} = 6.0A$ $T_{Vj} = 25^{\circ}C$ $T_{Vj} = 175^{\circ}C$		1.65 1.85	2.10	٧
Diode forward voltage	VF	$V_{GE} = 0V, \not = 6.0A$ $T_{vj} = 25^{\circ}C$ $T_{vj} = 175^{\circ}C$	1	1.70 1.70	2.10	٧
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	/c = 0.11mA, VcE = VGE	4.3	5.0	5.7	V
Zero gate voltage collector current <sup>1)</sup>	/ces	$V_{CE} = 600V$ , $V_{GE} = 0V$ $T_{vj} = 25^{\circ}C$ $T_{vj} = 175^{\circ}C$	7.		40.0 1000.0	μA
Gate-emitter leakage current	/GES	V <sub>CE</sub> = 0V, V <sub>GE</sub> = 20V	-	-	100	nA
Transconductance	$g_{fs}$	V <sub>CE</sub> = 20V, I <sub>C</sub> = 6.0A	-	3.4	-	S
Integrated gate resistor	<b>/</b> G			none		Ω

## Electrical Characteristic, at $T_{vj} = 25$ °C, unless otherwise specified

Parameter	Symbol Conditions		Value			Unit
Faranteter			min.	typ.	max.	Oilit
Dynamic Characteristic						
Input capacitance	Cies			470	37	
Output capacitance	Coes	$V_{CE} = 25V$ , $V_{GE} = 0V$ , $f = 1MHz$	-	24		pF
Reverse transfer capacitance	Cres		-	14	-	
Gate charge	$Q_{\mathrm{G}}$	$V_{CC} = 480V$ , $I_{C} = 6.0A$ , $V_{GE} = 15V$	-	48.0	-	nC
Short circuit collector current Max. 1000 short circuits Time between short circuits: ≥ 1.0s	<b>/</b> c(sc)	$V_{GE} = 15.0V$ , $V_{CC} \le 400V$ , $t_{SC} \le 5\mu s$ $T_{Vj} = 25^{\circ}C$	-	46		Α

#### Switching Characteristic, Inductive Load, at Tvj = 25°C

Parameter	O. walk at	Symbol Conditions	Value			11 14
	Symbol	Conditions	min.	typ.	max.	Unit
IGBT Characteristic				•	•	•
Turn-on delay time	<i>t</i> d(on)	$T_{\rm vj} = 25^{\circ}{\rm C},$	-	12	-	ns
Rise time	<i>t</i> r	$V_{CC} = 400 \text{V}, \ I_{C} = 6.0 \text{A}, \ V_{GE} = 0.0/15.0 \text{V}, \ I_{C} = 23.0 \Omega, \ I_{C} = 60 \text{nH}, \ I_{C} = 40 \text{pF}, \ I_{C}, \ I_{C} = 60 \text{nH}, \ I_{C} = 60$	-	7	-	ns
Turn-off delay time	<i>t</i> d(off)		-	127	-	ns
Fall time	<i>t</i> f		-	152	-	ns
Turn-on energy	E <sub>on</sub>		-	0.11	-	mJ
Turn-off energy	$E_{ m off}$		-	0.22	-	mJ
Total switching energy	<i>E</i> ts		-	0.33	-	mJ



#### TRENCHSTOP™ RC-Series for hard switching applications

#### Diode Characteristic, at $T_{vj} = 25^{\circ}C$

Diode reverse recovery time	<i>t</i> rr	$T_{\rm vj} = 25^{\circ}{\rm C},$	-	68	-	ns
Diode reverse recovery charge	$Q_{rr}$	V <sub>R</sub> = 400V,   <sub>F</sub> = 6.0A.	-	0.37	-	μC
Diode peak reverse recovery current	/ <sub>rrm</sub>	<i>di</i> ⊧/ <i>dt</i> = 800A/µs	-	12.0	-	Α
Diode peak rate of fall of reverse recovery current during &	di <sub>rr</sub> /dt		-	-211	-	A/µs

#### Switching Characteristic, Inductive Load, at $T_{vj}$ = 175°C

Parameter	Cymbol	Symbol Conditions		Value		
rarameter	Symbol Conditions		min.	typ.	max.	Unit
IGBT Characteristic			71			
Turn-on delay time	t <sub>d(on)</sub>	T <sub>vj</sub> = 175°C,	1	12	-	ns
Rise time	<i>t</i> r	$V_{CC} = 400V$ , $I_{C} = 6.0A$ , $V_{GE} = 0.0/15.0V$ ,	7-	10	-	ns
Turn-off delay time	t <sub>d(off)</sub>	$r_{\rm G} = 23.0\Omega$ , $L_{\rm \sigma} = 60$ nH,		164	-	ns
Fall time	<b>t</b> <sub>f</sub>	$C_{\sigma}$ = 40pF $L_{\sigma}$ , $C_{\sigma}$ from Fig. E	-	171	-	ns
Turn-on energy	Eon		- 1	0.20	-	mJ
Turn-off energy	Eoff		-	0.36	-	mJ
Total switching energy	Ets		-	0.56	-	mJ

#### Diode Characteristic, at $T_{vj}$ = 175°C

Diode reverse recovery time	<i>t</i> rr	$T_{\rm vj} = 175^{\circ}{\rm C},$	-	74	-	ns
Diode reverse recovery charge	Q <sub>rr</sub>	V <sub>R</sub> = 400V, √ <sub>E</sub> = 6.0A.	-	0.80		μC
Diode peak reverse recovery current	/rrm	<i>di</i> ⊧/ <i>dt</i> = 800A/µs	-	17.0	-	Α
Diode peak rate of fall of reverse recovery current during &	di <sub>rr</sub> /dt		-	-237	-	A/µs





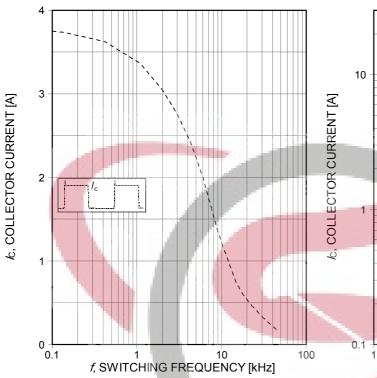


Figure 1. Collector current as a function of switching frequency  $(T_{vj} \le 175^{\circ}\text{C}, T_a = 55^{\circ}\text{C}, D = 0.5, V_{CE} = 400\text{V},$  $V_{\text{GE}}$ =15/0V,  $r_{\text{G}}$ =23 $\Omega$ , PCB mounting, 6cm2 Cu, Ptot=2,4W)

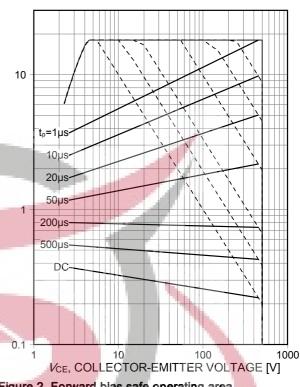


Figure 2. Forward bias safe operating area (*D*=0, *T*<sub>C</sub>=25°C, *T*<sub>vj</sub>≤175°C; *V*<sub>GE</sub>=1<mark>5V)</mark>

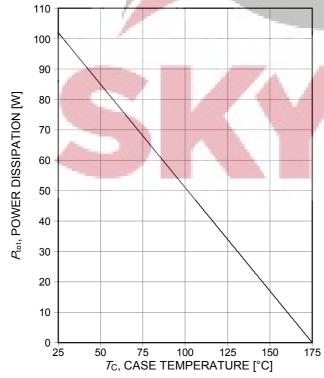


Figure 3. Power dissipation as a function of case temperature (*T*<sub>vj</sub>≤175°C)

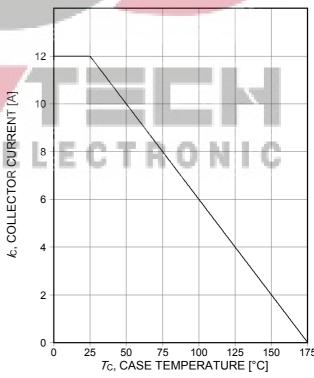


Figure 4. Collector current as a function of case temperature ( V<sub>GE</sub>≥15V, T<sub>vj</sub>≤175°C)

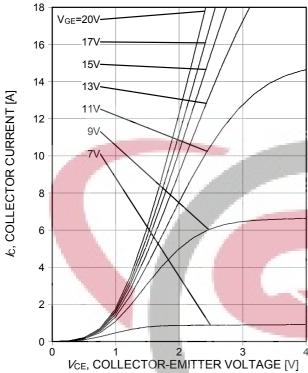


Figure 5. Typical output characteristic  $(\mathcal{T}_{vj}=25^{\circ}C)$ 

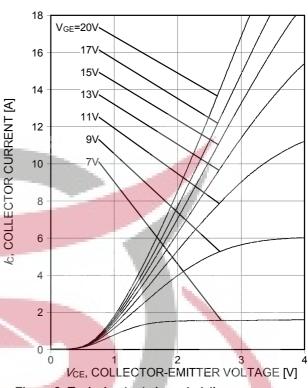


Figure 6. Typical output characteristic (T<sub>vj</sub>=175°C)

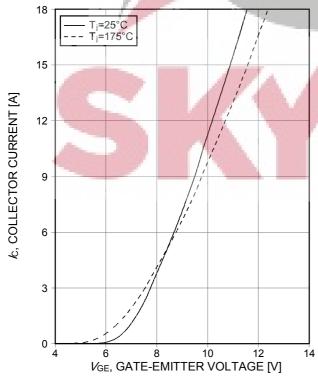


Figure 7. Typical transfer characteristic  $(V_{CE}=10V)$ 

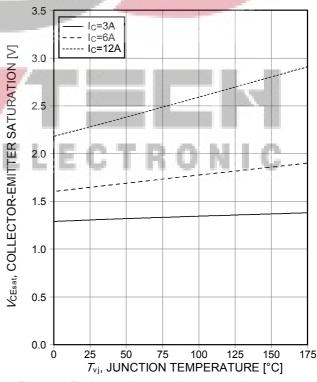


Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature (  $V_{\rm GE}$ =15V)

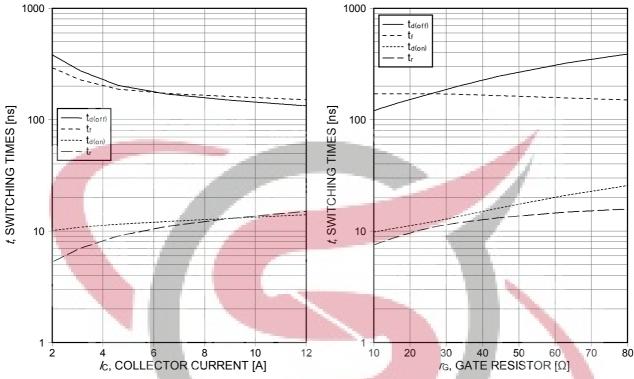
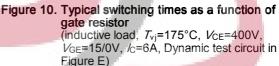


Figure 9. Typical switching times as a function of collector current (inductive load, Tvj=175°C, VCE=400V,

 $V_{GE}=15/0V$ ,  $r_{G}=23\Omega$ , Dynamic test circuit in Figure E)



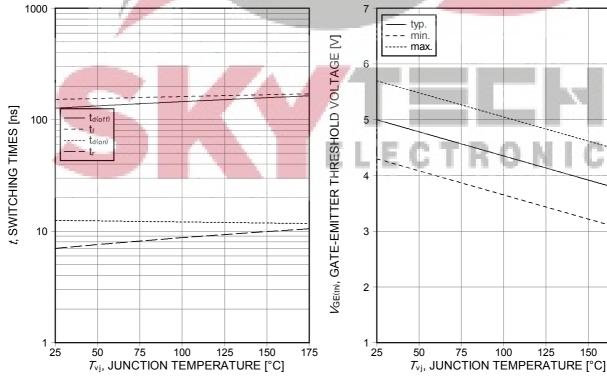


Figure 11. Typical switching times as a function of junction temperature

(inductive load,  $V_{CE}$ =400V,  $V_{GE}$ =15/0V,  $I_C$ =6A,  $I_C$ =23Ω, Dynamic test circuit in Figure E)

Figure 12. Gate-emitter threshold voltage as a function of junction temperature (/c=0.11mA)

150

175





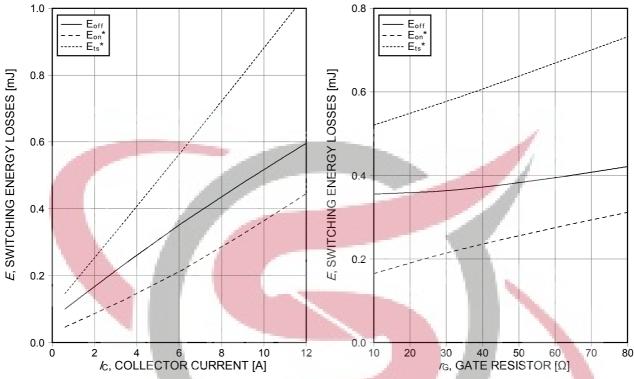


Figure 13. Typical switching energy losses as a function of collector current (inductive load, T<sub>vj</sub>=175°C, V<sub>CE</sub>=400V, V<sub>GE</sub>=15/0V, r<sub>G</sub>=23Ω, Dynamic test circuit in Figure E)

Figure 14. Typical switching energy losses as a function of gate resistor (inductive load,  $T_{\rm Vi}$ =175°C,  $V_{\rm CE}$ =400V,  $V_{\rm GE}$ =15/0V,  $I_{\rm CE}$ =6A, Dynamic test circuit in Figure E)

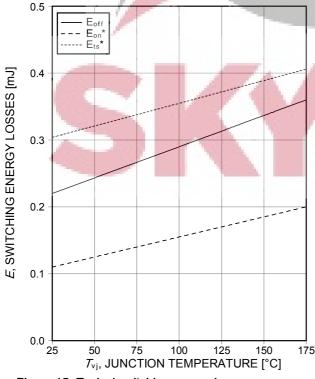


Figure 15. Typical switching energy losses as a function of junction temperature (inductive load, V<sub>CE</sub>=400V, V<sub>GE</sub>=15/0V, I<sub>C</sub>=6A, I<sub>C</sub>=23Ω, Dynamic test circuit in Figure E)

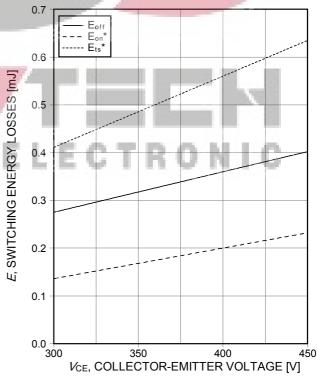


Figure 16. Typical switching energy losses as a function of collector emitter voltage (inductive load, T<sub>vj</sub>=175°C, V<sub>GE</sub>=15/0V, I<sub>C</sub>=6A, I<sub>G</sub>=23Ω, Dynamic test circuit in Figure E)

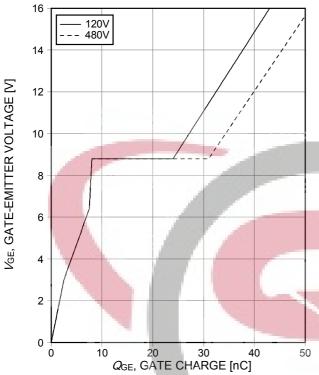


Figure 17. Typical gate charge (/c=6A)

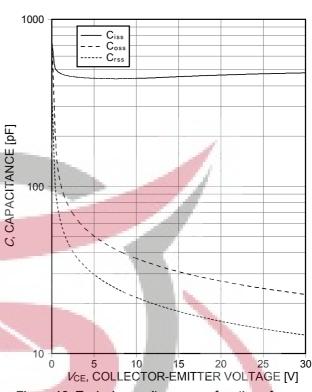


Figure 18. Typical capacitance as a function of collector-emitter voltage (VGE=0V, f=1MHz)

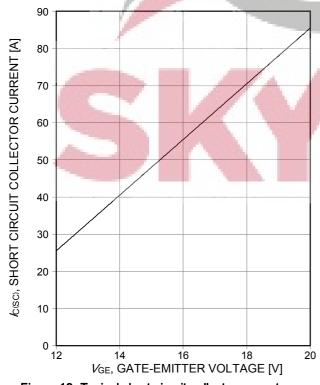


Figure 19. Typical short circuit collector current as a function of gate-emitter voltage ( $V_{\text{CE}} \le 400\text{V}$ , start at  $T_{\text{vj}} = 25^{\circ}\text{C}$ )

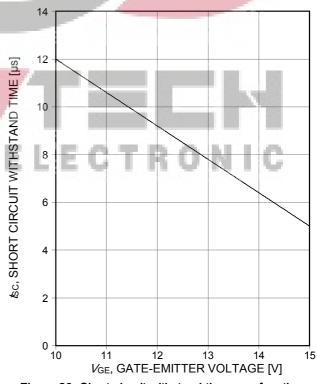


Figure 20. Short circuit withstand time as a function of gate-emitter voltage  $(V_{\text{CE}} \le 400\text{V}, \text{ start at } T_{\text{vj}} \le 150^{\circ}\text{C})$ 



# Zh(j-c), TRANSIENT THERMAL IMPEDANCE [K/W] D=0.5 0.050.02 0.01 0.1 single pulse

Figure 21. IGBT transient thermal impedance as a function of pulse width 1) (see page 4)  $(D=t_p/T)$ 

1E-4 0.001

to, PULSE WIDTH [s]

0.01

1E-7

1E-6

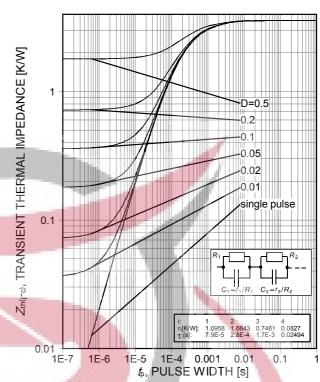


Figure 22. Diode transient thermal impedance as a function of pulse width 2) (see page 4)  $(D=t_p/T)$ 

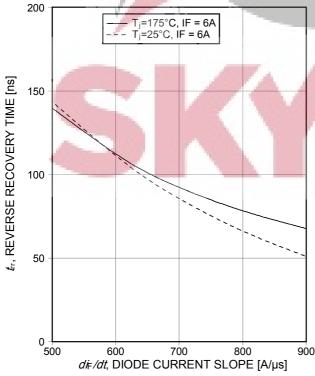


Figure 23. Typical reverse recovery time as a function of diode current slope ( V<sub>R</sub>=400V)

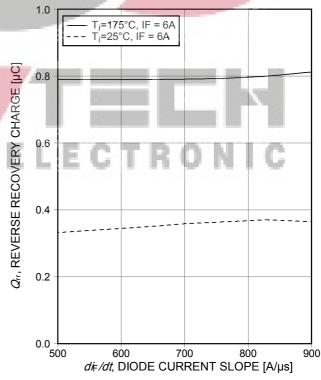


Figure 24. Typical reverse recovery charge as a function of diode current slope (V<sub>R</sub>=400V)

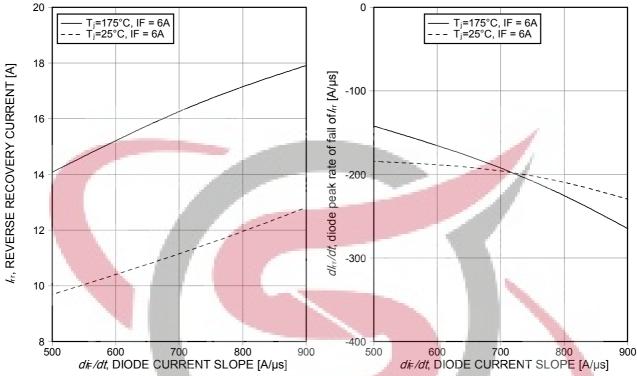


Figure 25. Typical reverse recovery current as a function of diode current slope (V<sub>R</sub>=400V)

Figure 26. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope

( \( \subset \mathbb{R} = 400V \)

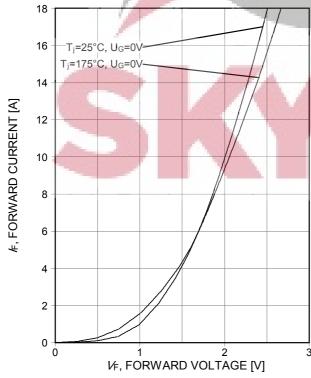


Figure 27. Typical diode forward current as a function of forward voltage

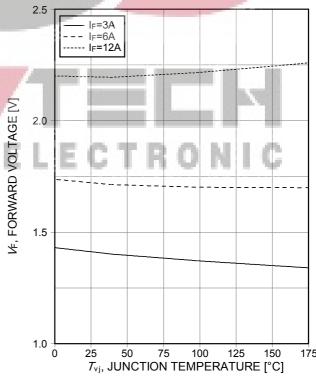
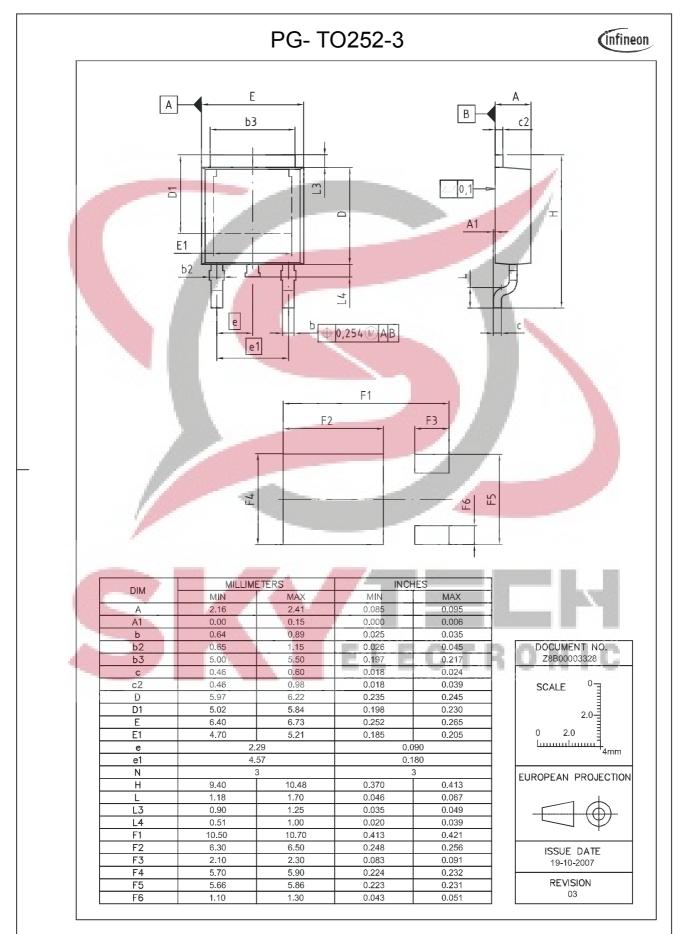


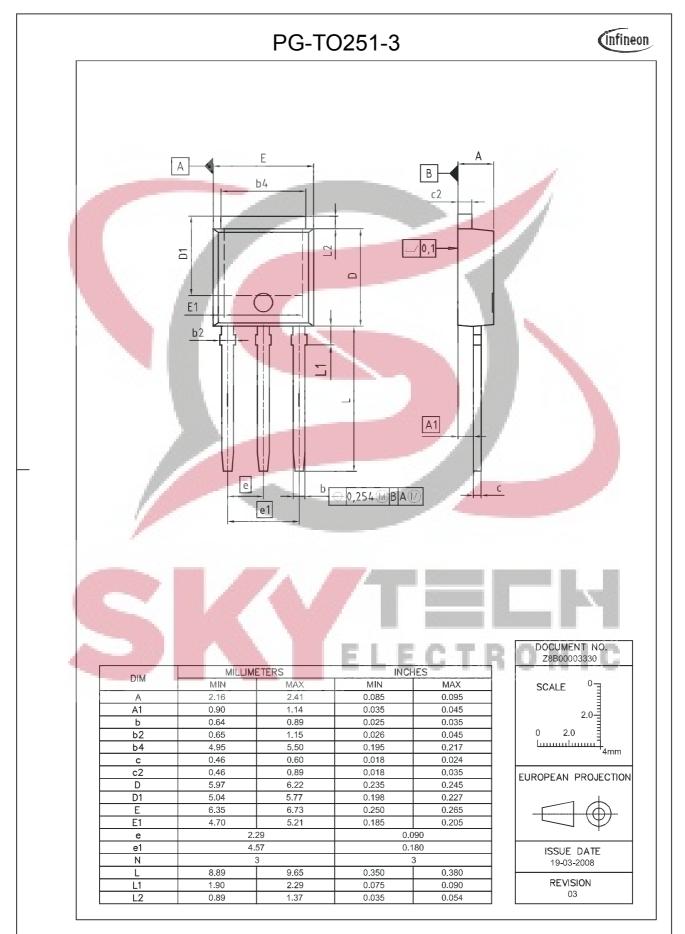
Figure 28. Typical diode forward voltage as a function of junction temperature



# TRENCHSTOP<sup>TM</sup> RC-Series for hard switching applications









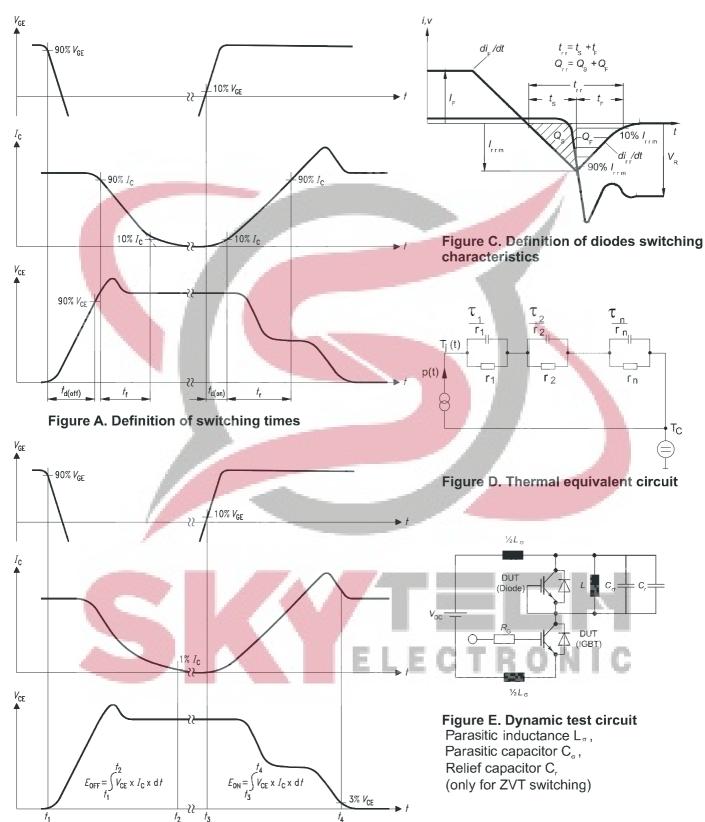


Figure B. Definition of switching losses



#### TRENCHSTOP™ RC-Series for hard switching applications

#### **Revision History**

IKD06N60R, IKU06N60R

Revision: 2011-01-17, Rev. 2.1

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
1.2	2010-01-12	-				
2.1	-	Release of final datasheet				

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